SDAS072B - DECEMBER 1982 - REVISED JANUARY 1995

- Driver Version of 'AS32
- High Capacitive-Drive Capability
- Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

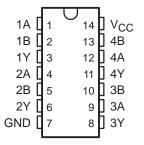
These devices contain four independent 2-input positive-OR buffers/drivers. They perform the Boolean functions Y = A + B or $Y = \overline{A} \bullet \overline{B}$ in positive logic.

The SN54AS1032A is characterized for operation over the full military temperature range of -55° C to 125°C. The SN74AS1032A is characterized for operation from 0°C to 70°C.

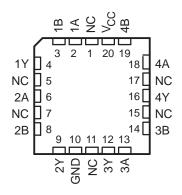
FUNCTION TABLE (each gate)

INP	UTS	OUTPUT
Α	В	Y
Н	Х	Н
Χ	Н	Н
L	L	L

SN54AS1032A . . . J PACKAGE SN74AS1032A . . . D OR N PACKAGE (TOP VIEW)



SN54AS1032A . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

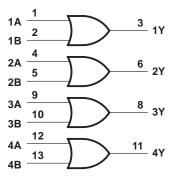
logic symbol†

	1		1	
1A	2	≥1▷	3	1Y
1B 2A	4		_	
2A 2B	5		6	2Y
2B 3A	9			
3A	10		8	3Y
3B 4A	12		44	
4A 4B	13		11	4Y
4D				

[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, J, and N packages.

logic diagram (positive logic)



SN54AS1032A, SN74AS1032A QUADRUPLE 2-INPUT POSITIVE-OR BUFFERS/DRIVERS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC}	7 V
Input voltage, V _I	7 V
Operating free-air temperature range, T _A : SN54AS1032A	–55°C to 125°C
SN74AS1032A	0°C to 70°C
Storage temperature range	–65°C to 150°C

recommended operating conditions‡

		SN54AS1032A			SN74AS1032A			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.8			0.8	V
IOH	High-level output current			-40			-48	mA
loL	Low-level output current			40			48	mA
T _A	Operating free-air temperature	-55		125	0		70	°C

[‡]These high sink- or source-current devices are not recommended for use above 40 MHz.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN5	4AS103	2A	SN74AS1032A			UNIT	
PARAMETER			MIN	TYP§	MAX	MIN	TYP§	MAX	UNIT	
VIK	$V_{CC} = 4.5 \text{ V},$	I _I = -18 mA			-1.2			-1.2	V	
	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	V _{CC} -2			V _{CC} -2				
VOH		$I_{OH} = -3 \text{ mA}$	2.4	3.2		2.4	3.2		V	
	V _{CC} = 4.5 V	$I_{OH} = -40 \text{ mA}$	2						V	
		$I_{OH} = -48 \text{ mA}$				2				
V	V _{CC} = 4.5 V	$I_{OL} = 40 \text{ mA}$		0.25	0.5				V	
VOL		$I_{OL} = 48 \text{ mA}$					0.35	0.5	V	
lį	$V_{CC} = 5.5 \text{ V},$	V _I = 7 V			0.1			0.1	mA	
ΙΗ	$V_{CC} = 5.5 \text{ V},$	V _I = 2.7 V			20			20	μΑ	
I _{IL}	$V_{CC} = 5.5 \text{ V},$	V _I = 0.4 V			-0.5			-0.5	mA	
ΙΟ [¶]	$V_{CC} = 5.5 \text{ V},$	V _O = 2.25 V	-50		-200	-50		-200	mA	
^I ССН	$V_{CC} = 5.5 V,$	V _I = 4.5 V		7.7	11.5		7.7	11.5	mA	
l _{CCL}	$V_{CC} = 5.5 V,$	V _I = 0		14.7	24		14.7	24	mA	

[§] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, los.

SN54AS1032A, SN74AS1032A QUADRUPLE 2-INPUT POSITIVE-OR BUFFERS/DRIVERS

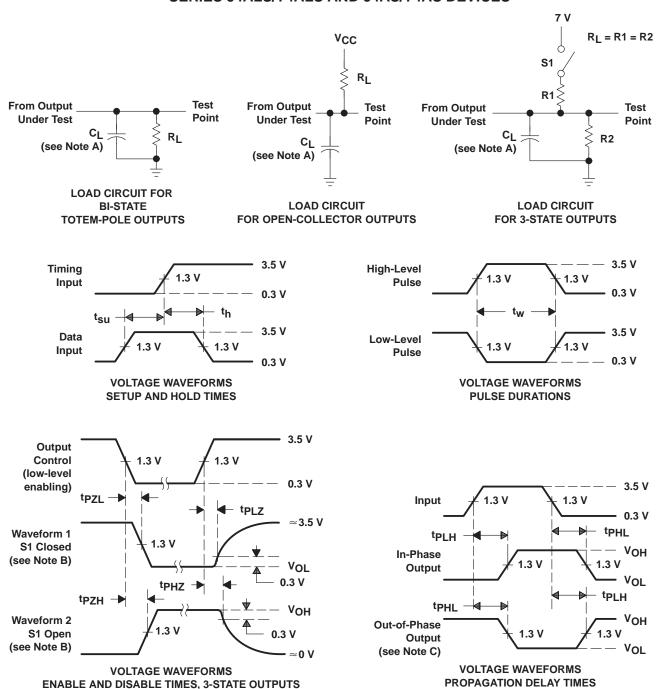
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switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω , T_A = MIN to MAX \dagger				UNIT
			SN54AS	1032A	SN74AS	1032A	
			MIN	MAX	MIN	MAX	
t _{PLH}	A or B	V	1	7	1	6.3	ns
^t PHL	AUIB	'	1	7	1	6.3	115

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C_L includes probe and jig capacitance.

- Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: $PRR \le 1$ MHz, $t_r = t_f = 2$ ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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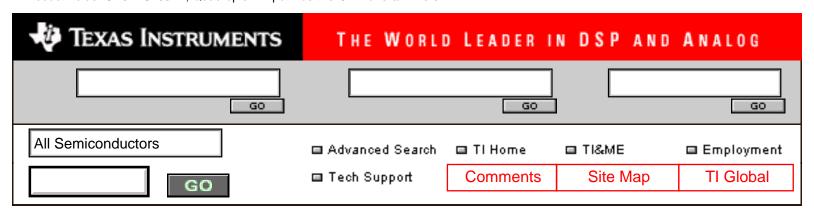
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SN54AS1032A, Quadruple 2-Input Positive-OR Buffers/Drivers

Device Status: Active

- > Description
- > Features
- > Datasheets
- > Pricing/Samples/Availability
- > Application Notes
- > Related Documents
- > Training

Parameter Name	SN54AS1032A				
Voltage Nodes (V)	5				
Output Level	TTL				

Description

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Features

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- High Capacitive-Drive Capability
- Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

To view the following documents, <u>Acrobat Reader 3.x</u> is required.

To download a document to your hard drive, right-click on the link and choose 'Save'.

Datasheets

Full datasheet in Acrobat PDF: <u>sdas072b.pdf</u> (79 KB) Full datasheet in Zipped PostScript: sdas072b.psz (74 KB)

Pricing/Samples/Availability

Orderable Device	Package	Pins	Temp (°C)	<u>Status</u>	Price/unit USD (100-999)	Pack Qty	DSCC Number	Availability / Samples
5962-88730012A	<u>FK</u>	20	-55 TO 125	OBSOLETE				
5962-8873001CA	J	14	-55 TO 125	ACTIVE	5.51	1		Check stock or order
5962-8873001DA	W	14	-55 TO 125	OBSOLETE				
SN54AS1032AJ	J	14	-55 TO 125	OBSOLETE				
SNJ54AS1032AFK	<u>FK</u>	20	-55 TO 125	OBSOLETE				
SNJ54AS1032AJ	J	14	-55 TO 125	ACTIVE	5.51	1		Check stock or order

Application Reports

View Application Reports for <u>Digital Logic</u>

- Advanced Schottky (ALS and AS) Logic Families (SDAA010 Updated: 08/01/1995)
- Advanced Schottky Load Management (SDYA016 Updated: 02/01/1997)
- Designing With Logic (SDYA009C Updated: 06/01/1997)
- Input And Output Characteristics Of Digital Integrated Circuits (SDYA010 Updated: 10/01/1996)
- <u>Live Insertion</u> (SDYA012 Updated: 10/01/1996)

Related Documents

- Documentation Rules (SAP) And Ordering Information (SZZU001B, 4 KB Updated: 05/06/1999)
- Logic Selection Guide Second Half 2000 (SDYU001N, 5035 KB Updated: 04/17/2000)
- MicroStar Junior BGA Design Summary (SCET004, 284 KB Updated: 07/28/2000)
- More Power In Less Space Technical Article (SCAU001A, 850 KB Updated: 03/01/1996)

Table Data Updated on: 9/1/2000

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